

FGA25N120ANTD 1200 V, 25 A NPT Trench IGBT

Features

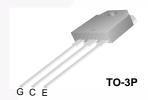
- NPT Trench Technology, Positive Temperature Coefficient
- Low Saturation Voltage: V_{CE(sat), typ} = 2.0 V
 Q I_C = 25 A and T_C = 25°C
- Low Switching Loss: $E_{off, typ} = 0.96 \text{ mJ}$ @ $I_C = 25 \text{ A}$ and $T_C = 25^{\circ}\text{C}$
- Extremely Enhanced Avalanche Capability

Applications

• Induction Heating, Microwave Oven



Using Fairchild's proprietary trench design and advanced NPT technology, the 1200V NPT IGBT offers superior conduction and switching performances, high avalanche ruggedness and easy parallel operation. This device is well suited for the resonant or soft switching application such as induction heating, microwave oven.





Absolute Maximum Ratings

Symbol	Description		Ratings	Unit
V _{CES}	Collector-Emitter Voltage		1200	V
V _{GES}	Gate-Emitter Voltage		± 20	V
I _C	Collector Current	@ $T_C = 25^{\circ}C$	50	A
	Collector Current	@ T _C = 100°C	25	A
I _{CM (1)}	Pulsed Collector Current		90	A
I _F	Diode Continuous Forward Current	@ T _C = 25°C	50	A
	Diode Continuous Forward Current	@ T _C = 100°C	25	A
I _{FM}	Diode Maximum Forward Current		150	A
P_{D}	Maximum Power Dissipation	@ T _C = 25°C	312	W
	Maximum Power Dissipation	@ T _C = 100°C	125	W
T _J	Operating Junction Temperature		-55 to +150	°C
T _{stg}	Storage Temperature Range		-55 to +150	°C
TL	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C

Notes:

(1) Repetitive rating: Pulse width limited by max. junction temperature

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
$R_{\theta JC}(IGBT)$	Thermal Resistance, Junction-to-Case		0.4	°C/W
$R_{\theta JC}(DIODE)$	Thermal Resistance, Junction-to-Case		2.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		40	°C/W

Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FGA25N120ANTDTU	FGA25N120ANTD	TO-3P	Tube	N/A	N/A	30

Electrical Characteristics of the IGBT $T_C = 25$ °C unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	teristics					
I _{CES}	Collector Cut-Off Current	$V_{CE} = V_{CES}, V_{GE} = 0 V$			3	mA
I _{GES}	G-E Leakage Current	$V_{GE} = V_{GES}, V_{CE} = 0 V$			± 250	nA
On Charac	teristics					
V _{GE(th)}	G-E Threshold Voltage	$I_C = 25 \text{ mA}, V_{CE} = V_{GE}$	3.5	5.5	7.5	V
V _{CE(sat)}	Collector to Emitter	I _C = 25 A, V _{GE} = 15 V	/	2.0		V
. ,	Saturation Voltage	$I_C = 25 \text{ A}, V_{GE} = 15 \text{ V},$ $T_C = 125^{\circ}\text{C}$		2.15		٧
		$I_C = 50 \text{ A}, V_{GE} = 15 \text{ V}$		2.65		V
Dynamic C	haracteristics					
C _{ies}	Input Capacitance	$V_{CE} = 30 \text{ V}, V_{GE} = 0 \text{ V},$		3700		pF
C _{oes}	Output Capacitance	f = 1 MHz		130		pF
C _{res}	Reverse Transfer Capacitance			80		pF
Switching	Characteristics					
$t_{d(on)}$	Turn-On Delay Time	$V_{CC} = 600 \text{ V}, I_{C} = 25 \text{ A},$ $R_{G} = 10 \Omega, V_{GE} = 15 \text{ V},$ Inductive Load, $T_{C} = 25^{\circ}\text{C}$		50		ns
t _r	Rise Time			60		ns
$t_{d(off)}$	Turn-Off Delay Time			190		ns
t _f	Fall Time			100		ns
E _{on}	Turn-On Switching Loss			4.1		mJ
E _{off}	Turn-Off Switching Loss			0.96		mJ
E _{ts}	Total Switching Loss		/	5.06		mJ
t _{d(on)}	Turn-On Delay Time	$V_{CC} = 600 \text{ V}, I_C = 25 \text{ A},$	/	50		ns
t _r	Rise Time	$R_G = 10 \Omega$, $V_{GE} = 15 V$, Inductive Load, $T_C = 125^{\circ}C$		60		ns
t _{d(off)}	Turn-Off Delay Time	madelive Edad, 1C = 123 O		200		ns
t _f	Fall Time			154		ns
E _{on}	Turn-On Switching Loss			4.3		mJ
E _{off}	Turn-Off Switching Loss			1.5		mJ
E _{ts}	Total Switching Loss			5.8	//	mJ
Qg	Total Gate Charge	$V_{CE} = 600 \text{ V}, I_{C} = 25 \text{ A},$		200		nC
Q _{ge}	Gate-Emitter Charge	V _{GE} = 15 V		15		nC
Q _{gc}	Gate-Collector Charge			100		nC

Electrical Characteristics of DIODE $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions		Min.	Тур.	Max.	Unit
V_{FM}	Diode Forward Voltage	I _F = 25 A	$T_C = 25^{\circ}C$		2.0	3.0	٧
			T _C = 125°C		2.1		
t _{rr}	Diode Reverse Recovery Time	I _F = 25 A	$T_C = 25^{\circ}C$		235	350	ns
		$di_F/dt = 200 A/\mu s$	T _C = 125°C		300		
I _{rr}	Diode Peak Reverse Recovery Cur-		$T_C = 25^{\circ}C$		27	40	Α
	rent		T _C = 125°C		31		
Q _{rr}	Diode Reverse Recovery Charge		$T_C = 25^{\circ}C$		3130	4700	nC
			T _C = 125°C		4650		

Typical Performance Characteristics

Figure 1. Typical Output Characteristics

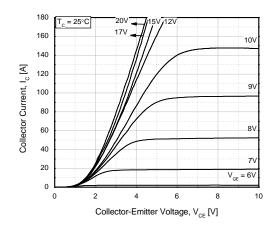


Figure 3. Saturation Voltage vs. Case
Temperature at Variant Current Level

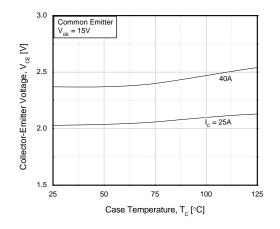


Figure 5. Saturation Voltage vs. V_{GE}

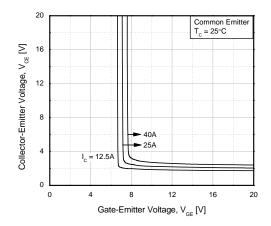


Figure 2. Typical Saturation Voltage Characteristics

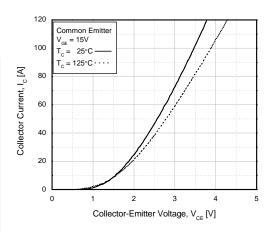


Figure 4. Saturation Voltage vs. V_{GE}

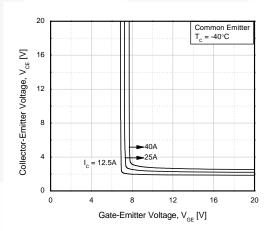
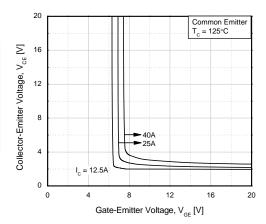


Figure 6. Saturation Voltage vs. V_{GE}



Typical Performance Characteristics (Continued)

Figure 7. Capacitance Characteristics

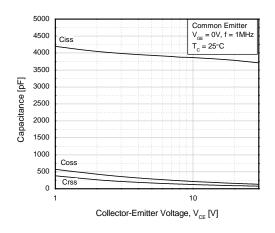


Figure 9. Turn-Off Characteristics vs. Gate Resistance

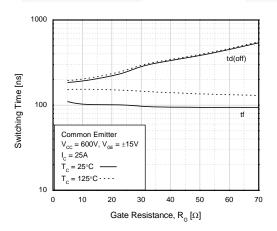


Figure 11. Turn-On Characteristics vs. Collector Current

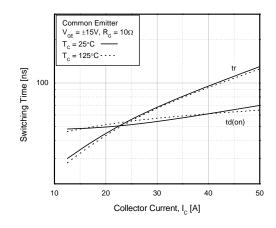


Figure 8. Turn-On Characteristics vs. Gate Resistance

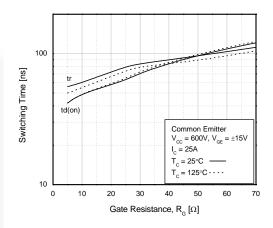


Figure 10. Switching Loss vs. Gate Resistance

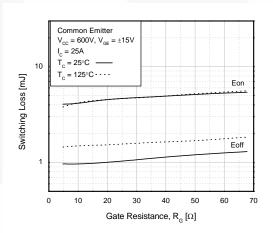
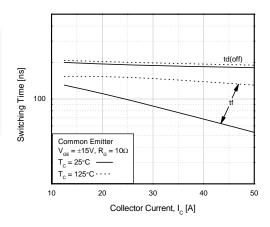
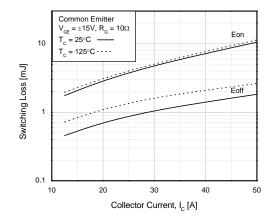


Figure 12. Turn-Off Characteristics vs.
Collector Current



Typical Performance Characteristics (Continued)

Figure 13. Switching Loss vs. Collector Current Figure 14. Gate Charge Characteristics



16 $R_{\rm L} = 24\Omega$ $T_{\rm c} = 25^{\circ}{\rm C}$ 12

Vcc = 200V

600V

400V

100 120 140 160

Gate Charge, Q_g [nC]

180

Figure 15. SOA Characteristics

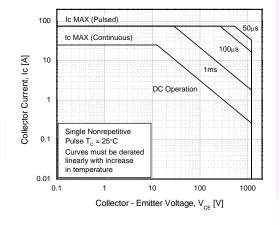


Figure 16. Turn-Off SOA

20

0

40 60

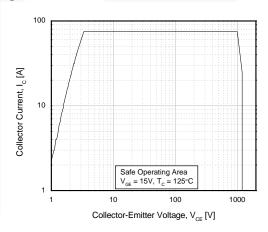
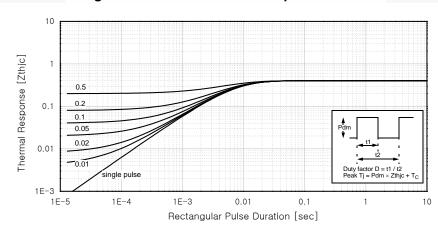


Figure 17. Transient Thermal Impedance of IGBT



Typical Performance Characteristics (Continued)

Figure 18. Forward Characteristics

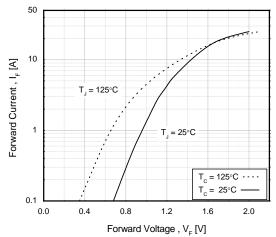


Figure 19. Reverse Recovery Current

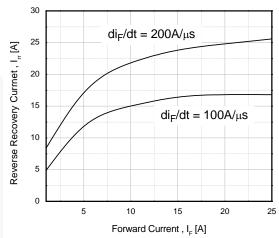


Figure 20. Stored Charge

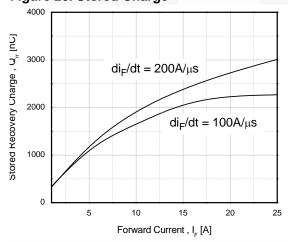
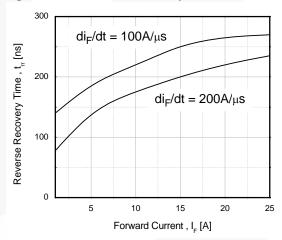


Figure 21. Reverse Recovery Time



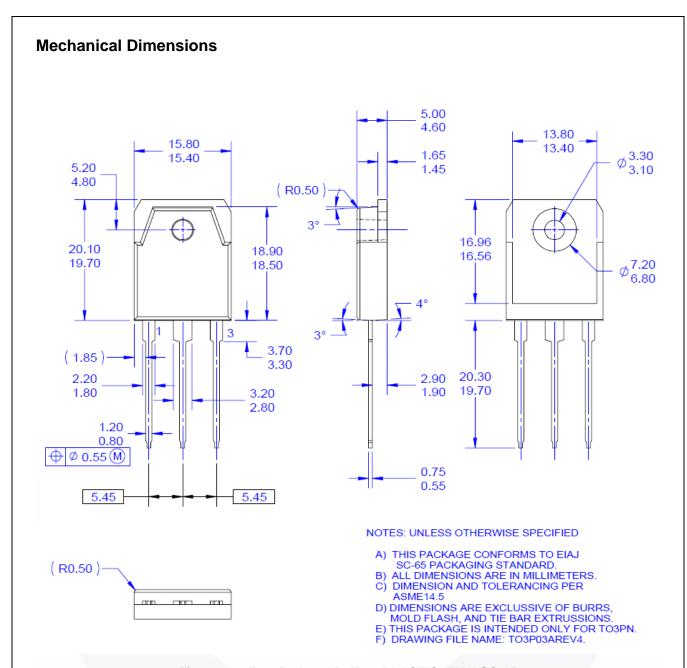


Figure 22. TO-3P 3L - 3LD, T03, PLASTIC, EIAJ SC-65

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Rev. 166